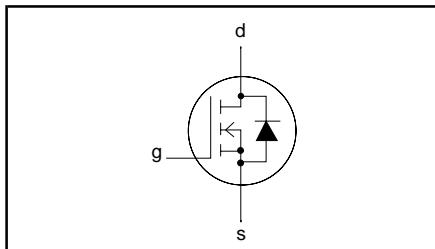


N-channel TrenchMOS™ transistor**PHW50NQ15T****FEATURES**

- 'Trench' technology
- Very low on-state resistance
- Fast switching
- Low thermal resistance

SYMBOL**QUICK REFERENCE DATA**

$V_{DSS} = 150 \text{ V}$
 $I_D = 50 \text{ A}$
 $R_{DS(ON)} \leq 35 \text{ m}\Omega$

GENERAL DESCRIPTION

N-channel enhancement mode field-effect power transistor in a plastic envelope using 'trench' technology.

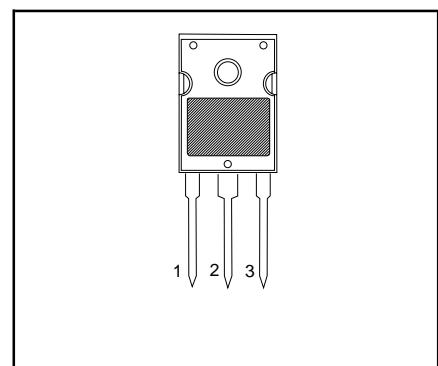
Applications:-

- d.c. to d.c. converters
- switched mode power supplies

The PHW50NQ15T is supplied in the SOT429 (TO247) conventional leaded package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | gate |
| 2 | drain |
| 3 | source |
| tab | drain |

SOT429 (TO247)**LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|----------------|--|---|------|----------|------------------|
| V_{DSS} | Drain-source voltage | $T_j = 25^\circ\text{C}$ to 175°C | - | 150 | V |
| V_{DGR} | Drain-gate voltage | $T_j = 25^\circ\text{C}$ to 175°C ; $R_{GS} = 20 \text{ k}\Omega$ | - | 150 | V |
| V_{GS} | Gate-source voltage | | - | ± 20 | V |
| I_D | Continuous drain current | $T_{mb} = 25^\circ\text{C}$ | - | 50 | A |
| | | $T_{mb} = 100^\circ\text{C}$ | - | 36 | A |
| I_{DM} | Pulsed drain current | $T_{mb} = 25^\circ\text{C}$ | - | 200 | A |
| P_D | Total power dissipation | $T_{mb} = 25^\circ\text{C}$ | - | 250 | W |
| T_j, T_{stg} | Operating junction and storage temperature | | -55 | 175 | $^\circ\text{C}$ |

AVALANCHE ENERGY LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|----------|----------------------------------|---|------|------|------|
| E_{AS} | Non-repetitive avalanche energy | Unclamped inductive load, $I_{AS} = 47 \text{ A}$; $t_p = 100 \mu\text{s}$; T_j prior to avalanche = 25°C ; $V_{DD} \leq 50 \text{ V}$; $R_{GS} = 50 \Omega$; $V_{GS} = 10 \text{ V}$; refer to fig;15 | - | 460 | mJ |
| I_{AS} | Non-repetitive avalanche current | | - | 50 | A |

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THERMAL RESISTANCES

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------------------|--|-------------|------|------|------|
| $R_{th\ j\text{-mb}}$ | Thermal resistance junction to mounting base | in free air | - | 0.6 | K/W |
| | Thermal resistance junction to ambient | | 45 | - | K/W |

ELECTRICAL CHARACTERISTICS $T_j = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|----------------------------------|---|---------------------------|------|------|------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}; T_j = -55^\circ\text{C}$ | 150 | - | - | V |
| | Gate threshold voltage | | 133 | - | - | V |
| | | | 2.0 | 3.0 | 4.0 | V |
| $R_{DS(ON)}$ | Drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}$ | 1.0 | - | - | V |
| | Gate source leakage current | | $T_j = 175^\circ\text{C}$ | - | - | V |
| | Zero gate voltage drain current | | $T_j = -55^\circ\text{C}$ | - | 6 | V |
| | | | - | 30 | 35 | mΩ |
| I_{GSS} | | $V_{GS} = \pm 10 \text{ V}; V_{DS} = 0 \text{ V}$ | - | - | 98 | mΩ |
| I_{DSS} | | | - | 2 | 100 | nA |
| $Q_{g(tot)}$ | Total gate charge | $I_D = 50 \text{ A}; V_{DD} = 120 \text{ V}; V_{GS} = 10 \text{ V}$ | - | 0.05 | 10 | μA |
| Q_{gs} | Gate-source charge | | - | - | 500 | μA |
| Q_{gd} | Gate-drain (Miller) charge | | - | - | - | μA |
| $t_{d\ on}$ | Turn-on delay time | $V_{DD} = 75 \text{ V}; R_D = 1.5 \Omega; V_{GS} = 10 \text{ V}; R_G = 5.6 \Omega$ Resistive load | - | 25 | - | ns |
| t_r | Turn-on rise time | | - | 138 | - | ns |
| $t_{d\ off}$ | Turn-off delay time | | - | 79 | - | ns |
| t_f | Turn-off fall time | | - | 93 | - | ns |
| L_d | Internal drain inductance | Measured from tab to centre of die Measured from drain lead to centre of die Measured from source lead to source bond pad | - | 3.5 | - | nH |
| L_d | Internal drain inductance | | - | 4.5 | - | nH |
| L_s | Internal source inductance | | - | 7.5 | - | nH |
| C_{iss} | Input capacitance | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ | - | 4720 | - | pF |
| C_{oss} | Output capacitance | | - | 456 | - | pF |
| C_{rss} | Feedback capacitance | | - | 208 | - | pF |

REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS $T_j = 25^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|----------|--|--|------|------|------|------|
| I_s | Continuous source current (body diode) | | - | - | 50 | A |
| I_{SM} | Pulsed source current (body diode) | | - | - | 200 | A |
| V_{SD} | Diode forward voltage | $I_F = 25 \text{ A}; V_{GS} = 0 \text{ V}$ | - | 0.85 | 1.2 | V |
| t_{rr} | Reverse recovery time | $I_F = 20 \text{ A}; -dI_F/dt = 100 \text{ A}/\mu\text{s}; V_{GS} = 0 \text{ V}; V_R = 30 \text{ V}$ | - | 118 | - | ns |
| Q_{rr} | Reverse recovery charge | | - | 0.66 | - | μC |

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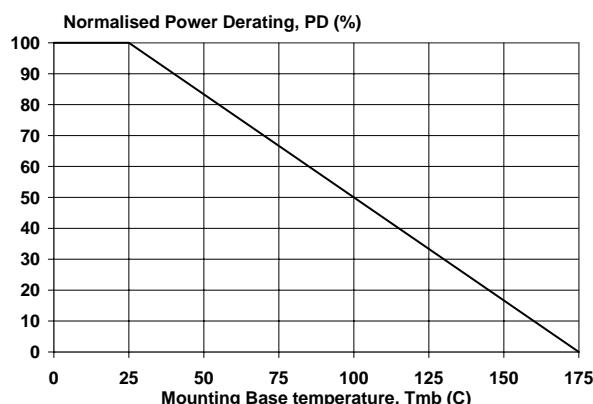


Fig.1. Normalised power dissipation.
 $PD\% = 100 \cdot P_D / P_{D, 25^\circ C} = f(T_{mb})$

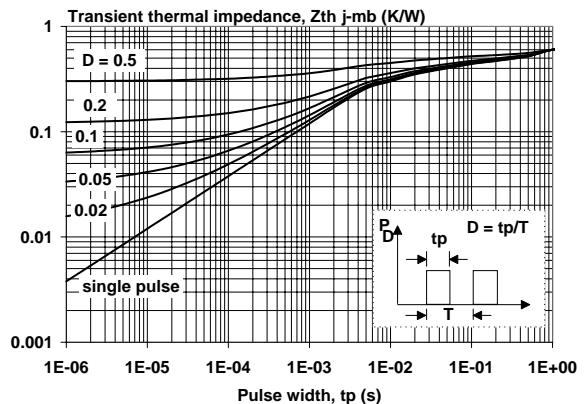


Fig.4. Transient thermal impedance.
 $Z_{th,j-mb} = f(t_p); \text{parameter } D = t_p/T$

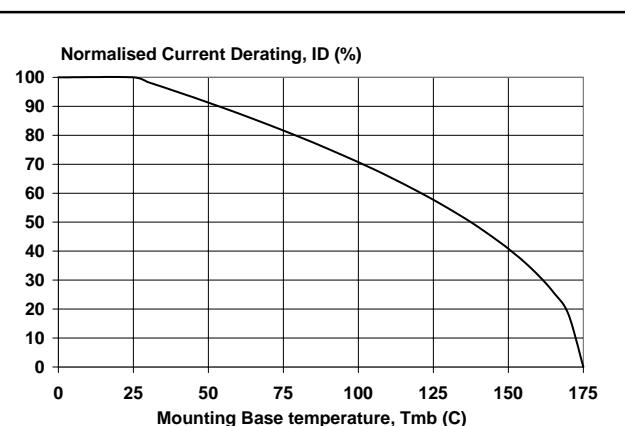


Fig.2. Normalised continuous drain current.
 $ID\% = 100 \cdot I_D / I_{D, 25^\circ C} = f(T_{mb})$

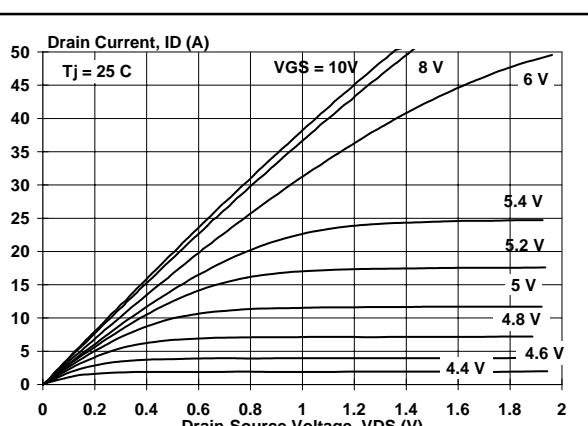


Fig.5. Typical output characteristics, $T_j = 25^\circ C$.
 $I_D = f(V_{DS}); \text{parameter } V_{GS}$

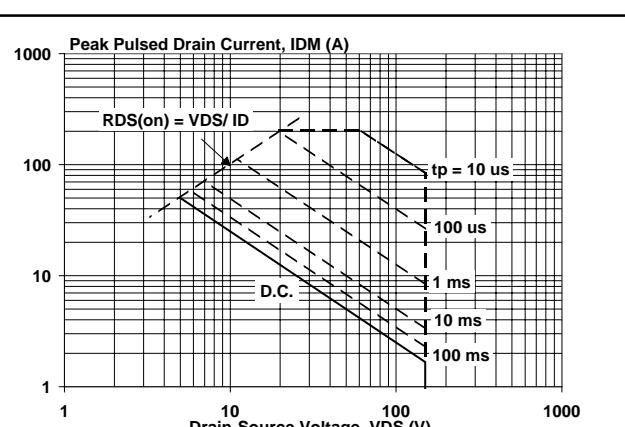


Fig.3. Safe operating area. $T_{mb} = 25^\circ C$
 $I_D \& I_{DM} = f(V_{DS}); I_{DM}$ single pulse; parameter t_p

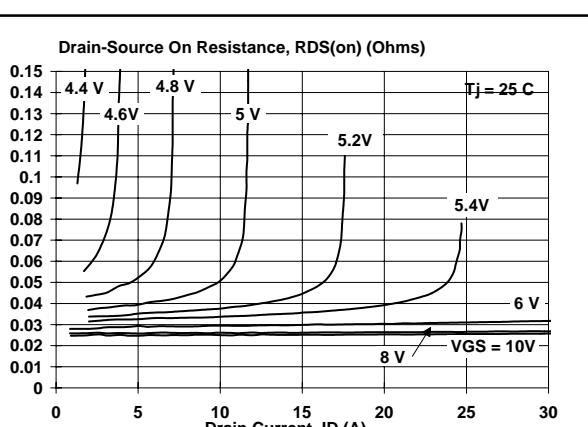


Fig.6. Typical on-state resistance, $T_j = 25^\circ C$.
 $R_{DS(ON)} = f(V_{GS})$

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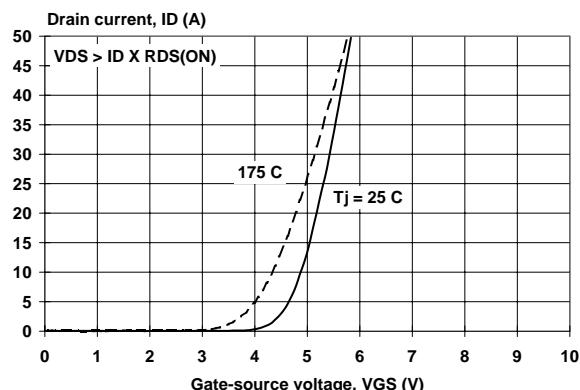


Fig.7. Typical transfer characteristics.
 $I_D = f(V_{GS})$; parameter T_j

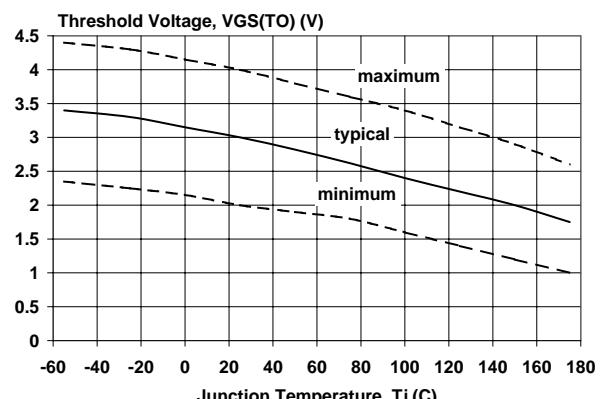


Fig.10. Gate threshold voltage.
 $V_{GS(TO)} = f(T_j)$; conditions: $I_D = 1$ mA; $V_{DS} = V_{GS}$

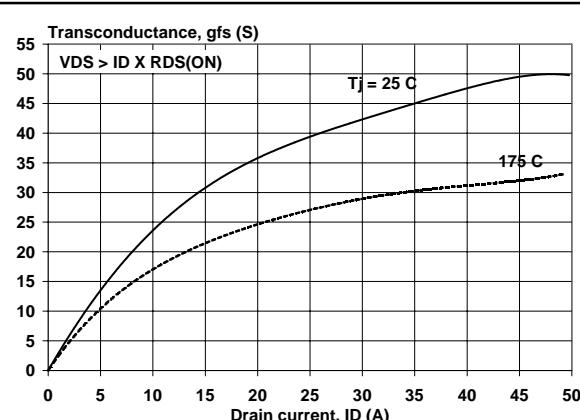


Fig.8. Typical transconductance, $T_j = 25$ °C.
 $g_{fs} = f(I_D)$

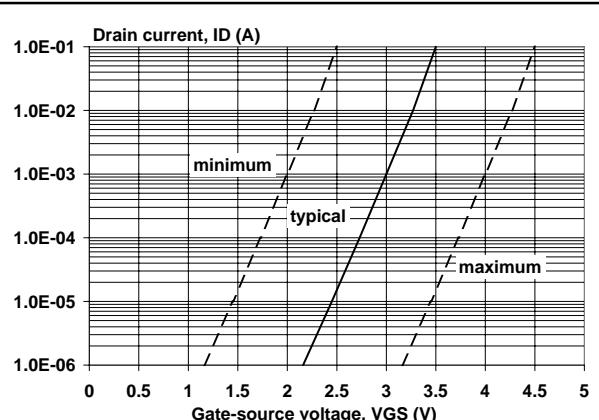


Fig.11. Sub-threshold drain current.
 $I_D = f(V_{GS})$; $T_j = 25$ °C

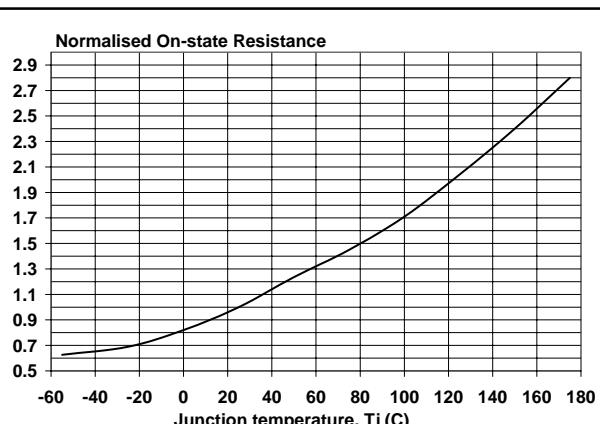


Fig.9. Normalised drain-source on-state resistance.
 $R_{DS(ON)}/R_{DS(ON)25\text{ }^{\circ}\text{C}} = f(T_j)$

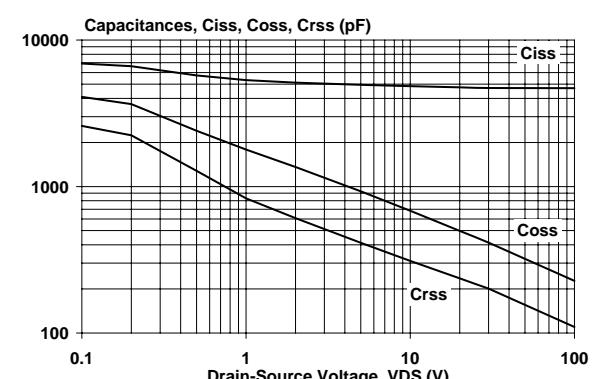


Fig.12. Typical capacitances, C_{iss} , C_{oss} , C_{rss} .
 $C = f(V_{DS})$; conditions: $V_{GS} = 0$ V; $f = 1$ MHz

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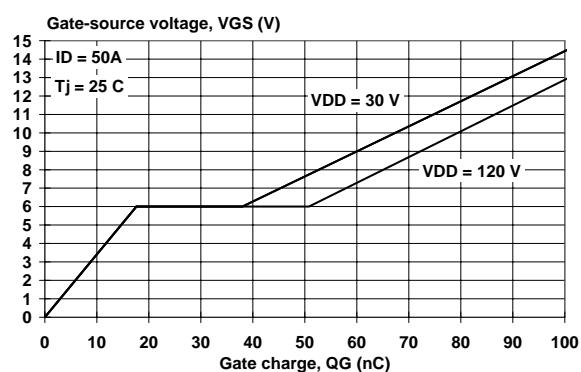


Fig.13. Typical turn-on gate-charge characteristics
 $V_{GS} = f(Q_G)$

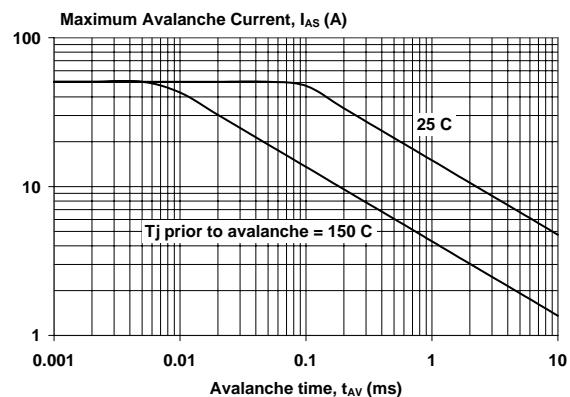


Fig.15. Maximum permissible non-repetitive avalanche current (I_{AS}) versus avalanche time (t_{AV}); unclamped inductive load

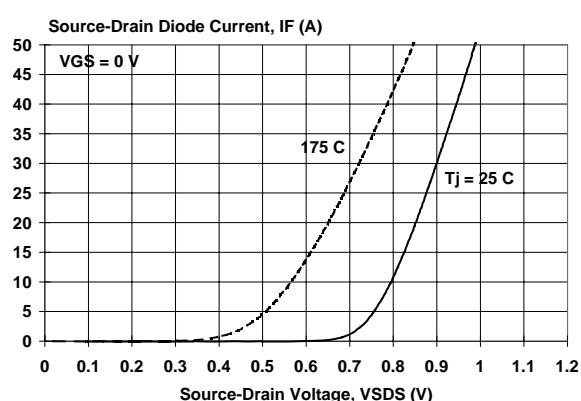


Fig.14. Typical reverse diode current.
 $I_F = f(V_{SDS})$; conditions: $V_{GS} = 0 V$; parameter T_j

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MECHANICAL DATA

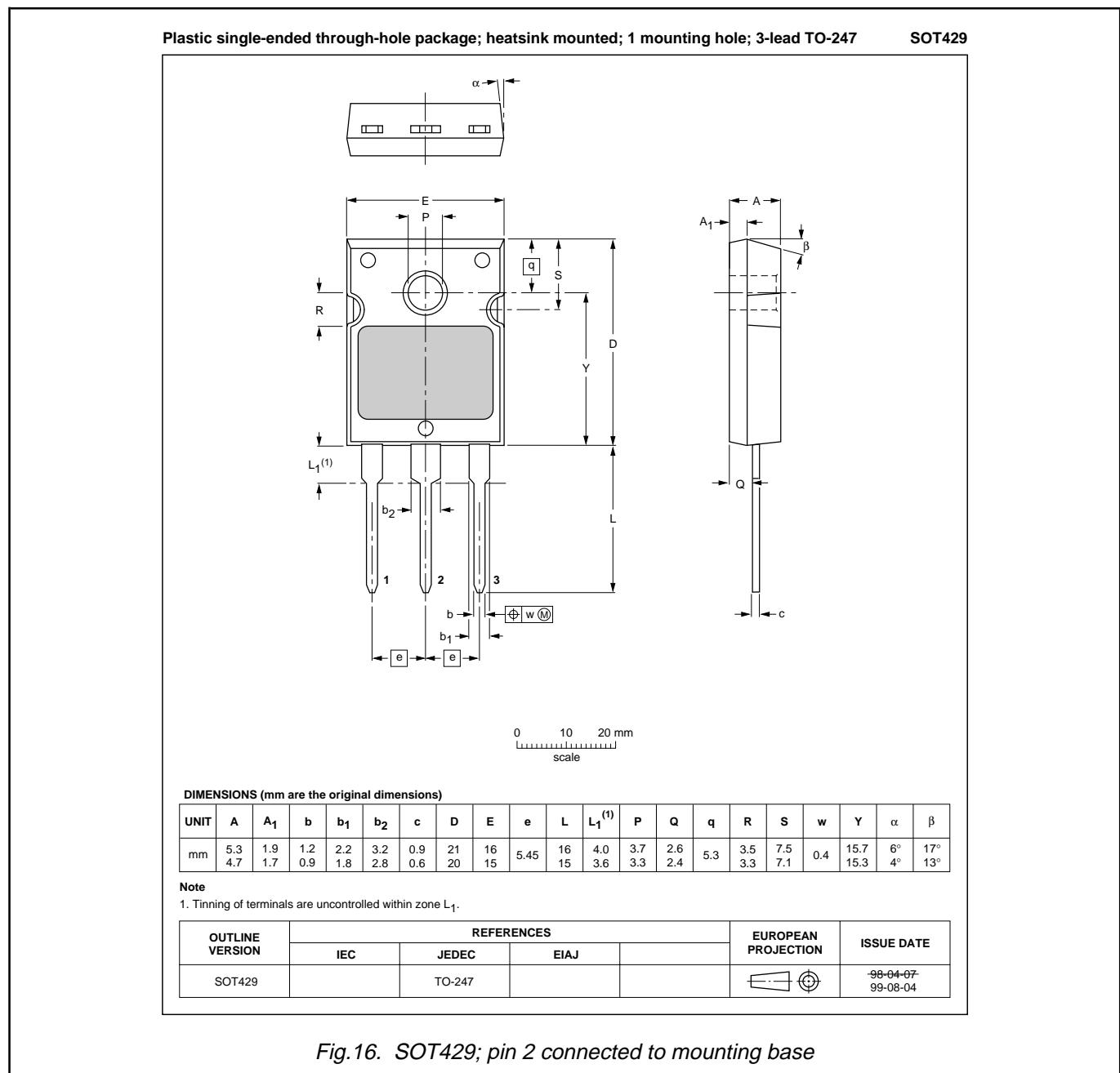


Fig.16. SOT429; pin 2 connected to mounting base

Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Refer to mounting instructions for SOT429 envelope.
3. Epoxy meets UL94 V0 at 1/8".

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DEFINITIONS

| Data sheet status | |
|--|---|
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | |
| Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability. | |
| Application information | |
| Where application information is given, it is advisory and does not form part of the specification. | |
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